

**Search Notes**

Application/Control No.

10/088,468

Examiner

Richard Lee

Applicant(s)/Patent under  
Reexamination

NISHIO ET AL.

Art Unit

2621

**SEARCHED**

Class	Subclass	Date	Examiner
375	240.02	8/1/2006	RL
Updated	Search	8/1/2006	RL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR